

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/080,729	EYER, MARK KENNETH	
Examiner		Art Unit		Page 1 of 1
ALBERT T. CHOU		2416		

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0201390	09-2005	Kikuchi, Takayuki	370/395.64
	B	US-			
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	E	US-			
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FOREIGN PATENT DOCUMENTS

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